

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 202135US0		SERIAL NO. 09/765,606	
LIST OF REFERENCES CITED BY APPLICANT <div style="position: absolute; top: 100px; left: 150px; border: 1px solid black; border-radius: 50%; padding: 5px; transform: rotate(-45deg);"> RECEIVED NOV 21 2003 </div>				APPLICANT Hiroshi NOJIRI, et al.			
				FILING DATE January 22, 2001		GROUP 1619	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
W	AO	0 714 655	06/05/96	EUROPE			X
	AP	WO 99/33443	07/08/99	WIPO			
W	AQ	WO 97/46246	12/11/97	WIPO (with English Abstract)			X
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
W	AW	Patent Abstracts of Japan, JP 10-279417, October 20, 1998					
	AX	Derwent Abstracts, JP 11-049646, February 23, 1990					
W	AY	Derwent Abstracts, JP 61-033129, February 17, 1986					
	AZ						
Examiner <i>WQ Wall</i>					Date Considered <i>3/22/04</i>		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Hiroshi NOJIRI, et al.

FILING DATE

January 22, 2001

GROUP

1617

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
LW	AA	5,484,597	01/16/96	C. S. SLAVTCHEFF, et al.			
	AB						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
LW	AO	11-139955	05/25/99	JAPAN (with English Abstract) ✓		X
	AP	10-279417	10/20/98	JAPAN (with English translation) ✓		
	AQ	9-500890	01/28/97	JAPAN (with English Abstract and corr. US 5,484,597)		X
	AR	2000-95667	04/04/2000	JAPAN (with English Abstract)		X
	AS	2000-119155	04/25/2000	JAPAN (with English Abstract)		X
LW	AT	2001-192339	07/17/2001	JAPAN (with English Abstract)		X
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	<input type="checkbox"/> Additional References sheet(s) attached

Examiner

RQ Welch

Date Consider 8/22/04

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	AA						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
XW	AO	JP 11-240827 A	09/07/99	Japan w/English abstract ✓		x
XW	AP	JP 6-293652A	10/21/94	Japan English Abstract Only		
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	<input type="checkbox"/> Additional References sheet(s) attached

Examiner

RQ Wells

Date Considered 3/22/01

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